

ZXMC3AMC

30V COMPLEMENTARY PAIR ENHANCEMENT MODE MOSFET

Product Summary

Device	V _{(BR)DSS}	R _{DS(on)} max	I _D max T _A = 25°C (Notes 4 & 7)
Q1	30V	120mΩ @ V _{GS} = 10V	3.7A
		180mΩ @ V _{GS} = 4.5V	3.0A
Q2	-30V	210mΩ @ V _{GS} = -10V	-2.7A
		330mΩ @ V _{GS} = -4.5V	-2.2A

Description and Applications

This MOSFET has been designed to minimize the on-state resistance (R_{DS(on)}) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

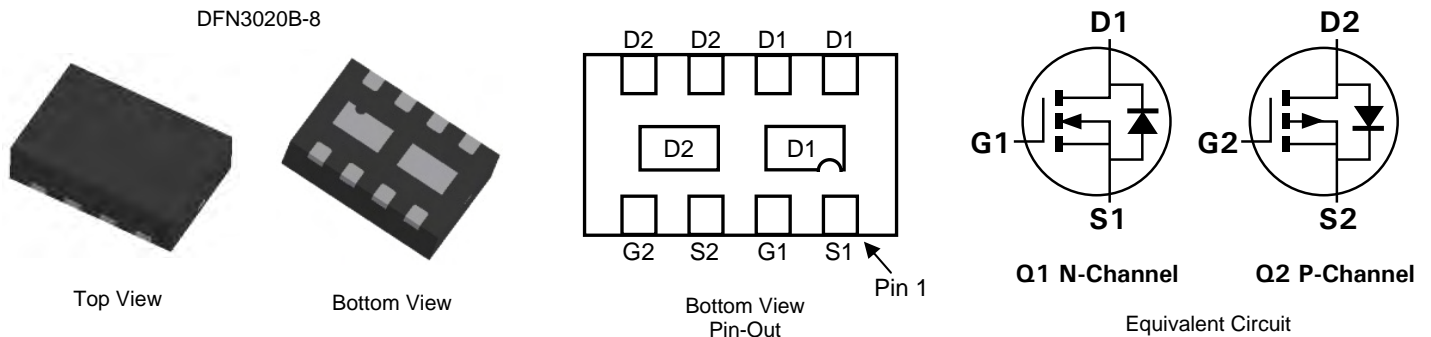
- MOSFET gate drive
- LCD backlight inverters
- Motor control
- Portable applications

Features and Benefits

- Low profile package, for thin applications
- Low R_{θJA}, thermally efficient package
- 6mm² footprint, 50% smaller than TSOP6 and SOT23-6
- Low on-resistance
- Fast switching speed
- "Lead-Free", RoHS Compliant (Note 1)
- Halogen and Antimony Free. "Green" Device (Note 2)
- Qualified to AEC-Q101 Standards for High Reliability

Mechanical Data

- Case: DFN3020B-8
- Terminals: Pre-Plated NiPdAu leadframe
- Nominal package height: 0.8mm
- UL Flammability Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Solderable per MIL-STD-202, Method 208
- Weight: 0.013 grams (approximate)

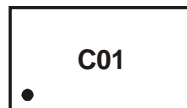


Ordering Information (Note 3)

Part Number	Marking	Reel size (inches)	Tape width (mm)	Quantity per reel
ZXMC3AMCTA	C01	7	8	3000

- Notes:
1. No purposefully added lead
 2. Diodes Inc's "Green" policy can be found on our website at <http://www.diodes.com>.
 3. For packaging details, go to our website at <http://www.diodes.com>.

Marking Information



C01 = Product Type Marking Code
Top view, Dot Denotes Pin 1

ZXMC3AMC

Maximum Ratings @T_A = 25°C unless otherwise specified

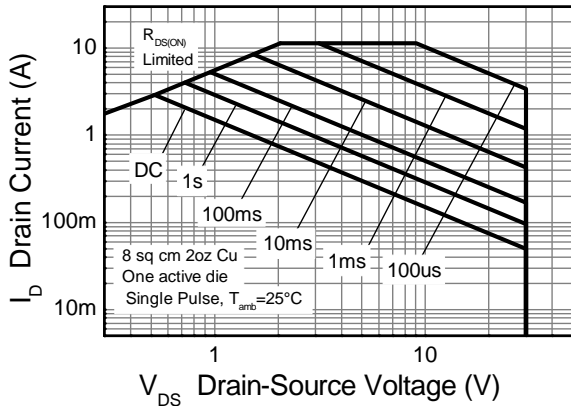
Characteristic			Symbol	N-channel – Q1	P-channel – Q2	Unit
Drain-Source Voltage			V _{DSS}	30	-30	V
Gate-Source Voltage			V _{GSS}	±20	±20	
Continuous Drain Current	V _{GS} = 10V	(Notes 4 & 7)	I _D	3.7	-2.7	A
		T _A = 70°C (Notes 4 & 7)		3.0	-2.2	
		(Notes 3 & 7)		2.9	-2.1	
Pulsed Drain Current	V _{GS} = 10V	(Notes 6 & 7)	I _{DM}	13	-9.2	
Continuous Source Current (Body diode)			I _S	3.2	-2.8	
Pulse Source Current (Body diode)			I _{SM}	13	-9.2	

Thermal Characteristics @T_A = 25°C unless otherwise specified

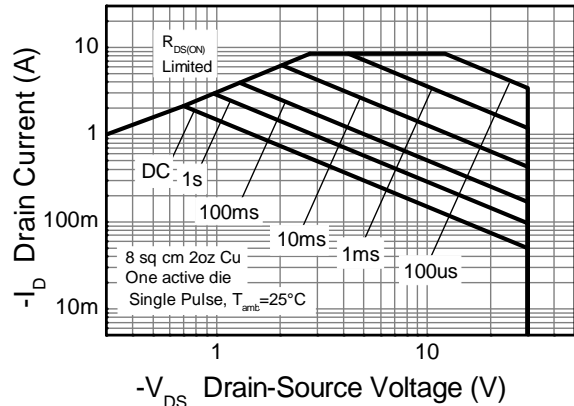
Characteristic		Symbol	N-channel – Q1	P-channel – Q2	Unit
Power Dissipation Linear Derating Factor	(Notes 3 & 7)	P _D	1.50		W mW/°C
	(Notes 4 & 7)		12		
	(Notes 5 & 7)		2.45		
	(Notes 5 & 8)		19.6		
	(Notes 5 & 8)		1.13		
Thermal Resistance, Junction to Ambient	(Notes 3 & 7)	R _{θJA}	9		°C/W
	(Notes 4 & 7)		1.70		
	(Notes 5 & 7)		13.6		
	(Notes 5 & 8)		83.3		
Thermal Resistance, Junction to Lead	(Notes 7 & 9)	R _{θJL}	51.0		
	(Notes 7 & 9)		111		
Operating and Storage Temperature Range		T _J , T _{STG}	73.5		
			17.1		
			-55 to +150		°C

- Notes:
3. For a device surface mounted on 28mm x 28mm (8cm²) FR4 PCB with high coverage of single sided 2oz copper, in still air conditions; the device is measured when operating in a steady-state condition. The heatsink is split in half with the exposed drain pads connected to each half.
 4. Same as note (3) except the device is measured at t < 5 sec.
 5. Same as note (3), except the device is surface mounted on 31mm x 31mm (10cm²) FR4 PCB with high coverage of single sided 1oz copper.
 6. Same as note (3), except the device is pulsed with D = 0.02 and pulse width 300µs. The pulse current is limited by the maximum junction temperature.
 7. For a dual device with one active die.
 8. For dual device with 2 active die running at equal power.
 9. Thermal resistance from junction to solder-point (at the end of the drain lead).

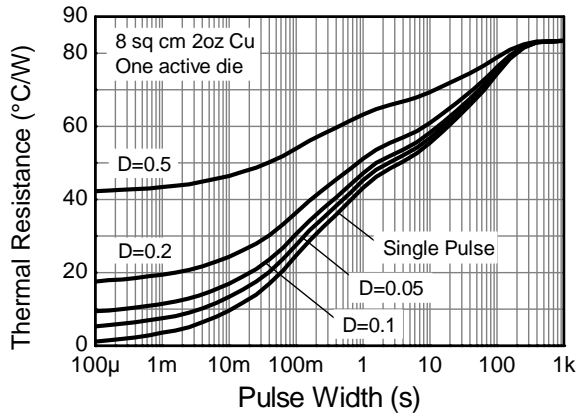
Thermal Characteristics



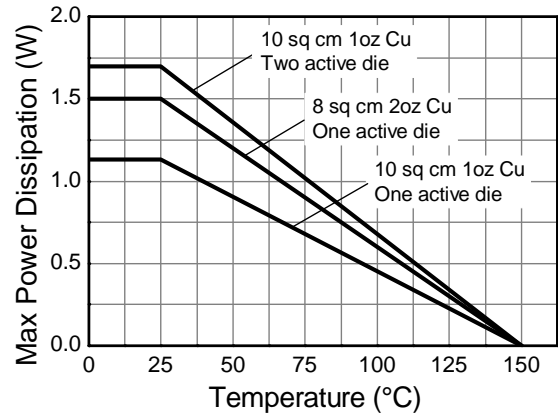
N-channel Safe Operating Area



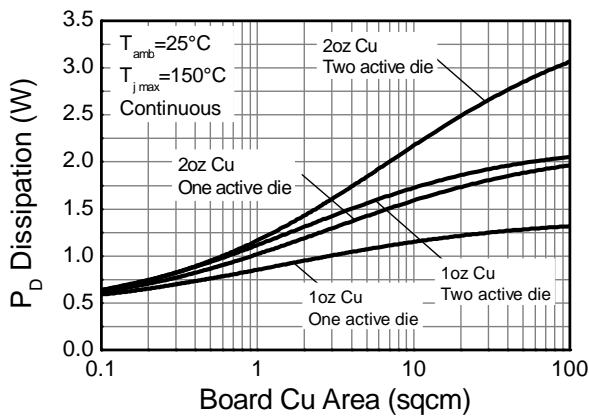
P-channel Safe Operating Area



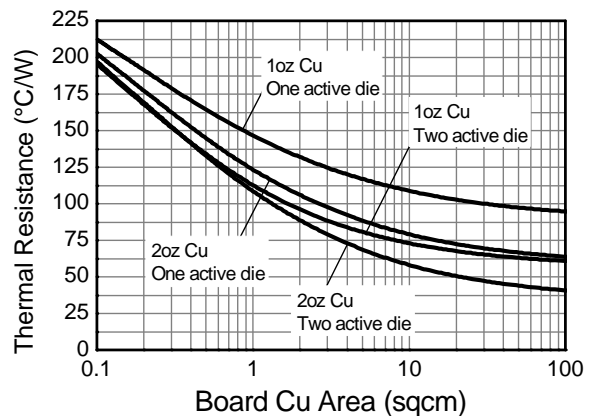
Transient Thermal Impedance



Derating Curve



Power Dissipation v Board Area



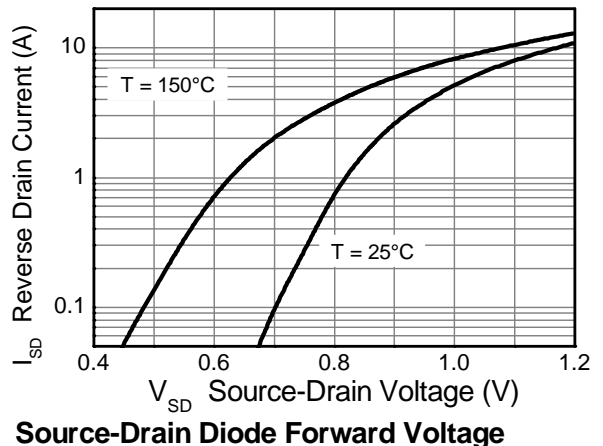
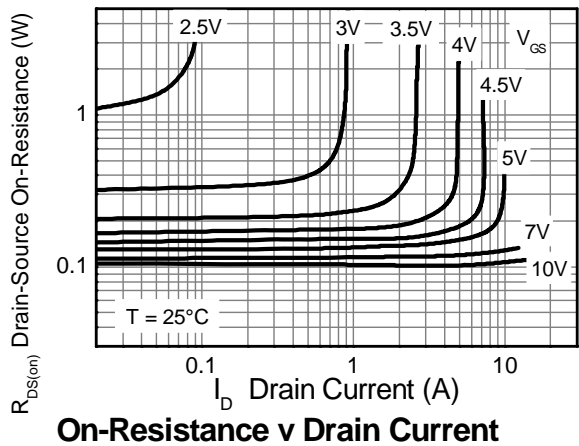
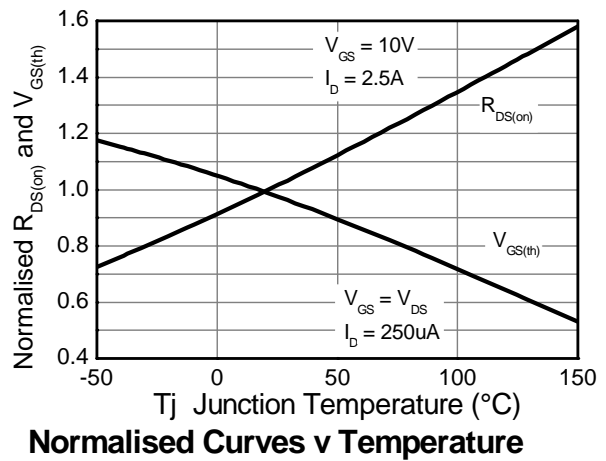
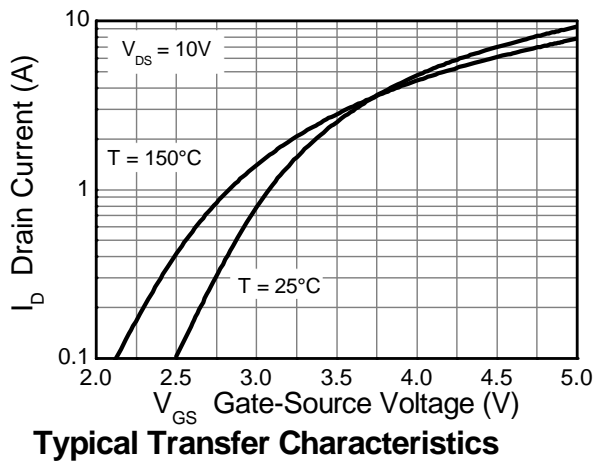
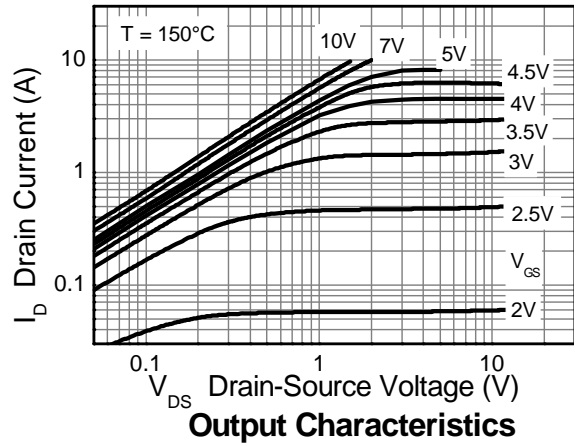
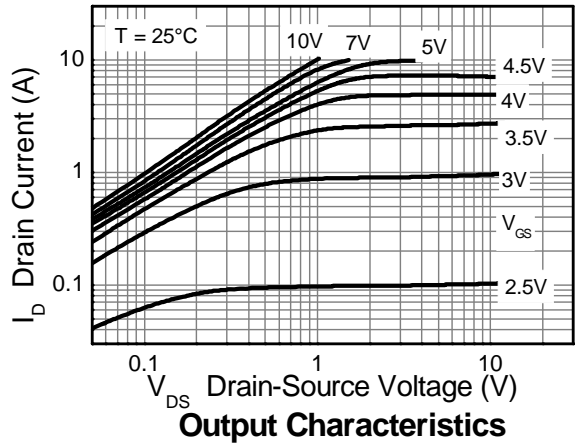
Thermal Resistance v Board Area

Electrical Characteristics – Q1 N-Channel @ $T_A = 25^\circ\text{C}$ unless otherwise specified

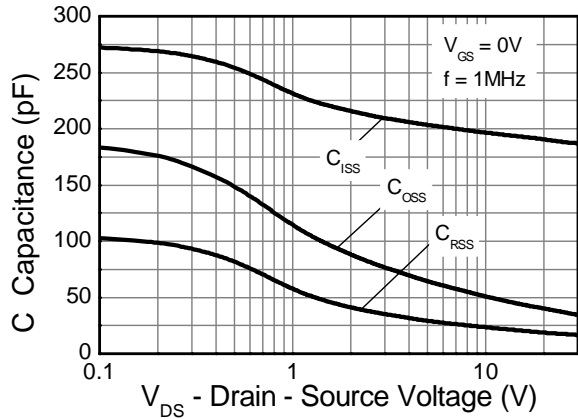
Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV_{DSS}	30	-	-	V	$I_D = 250\mu\text{A}, V_{GS} = 0\text{V}$
Zero Gate Voltage Drain Current	I_{DSS}	-	-	0.5	μA	$V_{DS} = 30\text{V}, V_{GS} = 0\text{V}$
Gate-Source Leakage	I_{GSS}	-	-	± 100	nA	$V_{GS} = \pm 20\text{V}, V_{DS} = 0\text{V}$
ON CHARACTERISTICS						
Gate Threshold Voltage	$V_{GS(th)}$	1.0	-	3.0	V	$I_D = 250\mu\text{A}, V_{DS} = V_{GS}$
Static Drain-Source On-Resistance (Note 10)	$R_{DS(on)}$	-	0.100	0.120	Ω	$V_{GS} = 10\text{V}, I_D = 2.5\text{A}$
			0.140	0.180		$V_{GS} = 4.5\text{V}, I_D = 2.0\text{A}$
Forward Transconductance (Note 10 & 11)	g_{fs}	-	3.5	-	S	$V_{DS} = 10\text{V}, I_D = 2.5\text{A}$
Diode Forward Voltage (Note 10)	V_{SD}	-	0.85	0.95	V	$I_S = 1.7\text{A}, V_{GS} = 0\text{V}$
Reverse Recover Time (Note 11)	t_{rr}	-	17.7	-	ns	$I_S = 2.5\text{A}, di/dt = 100\text{A}/\mu\text{s}$
Reverse Recover Charge (Note 11)	Q_{rr}	-	13.0	-	nC	
DYNAMIC CHARACTERISTICS (Note 11)						
Input Capacitance	C_{iss}	-	190	-	pF	$V_{DS} = 25\text{V}, V_{GS} = 0\text{V}, f = 1.0\text{MHz}$
Output Capacitance	C_{oss}	-	38	-	pF	
Reverse Transfer Capacitance	C_{rss}	-	20	-	pF	
Total Gate Charge (Note 12)	Q_g	-	2.3	-	nC	$V_{GS} = 4.5\text{V}$
Total Gate Charge (Note 12)	Q_g	-	3.9	-	nC	$V_{GS} = 10\text{V}$
Gate-Source Charge (Note 12)	Q_{gs}	-	0.6	-	nC	
Gate-Drain Charge (Note 12)	Q_{gd}	-	0.9	-	nC	
Turn-On Delay Time (Note 12)	$t_{D(on)}$	-	1.7	-	ns	$V_{DS} = 15\text{V}, I_D = 2.5\text{A}$ $V_{GS} = 10\text{V}, R_G = 6\Omega$
Turn-On Rise Time (Note 12)	t_r	-	2.3	-	ns	
Turn-Off Delay Time (Note 12)	$t_{D(off)}$	-	6.6	-	ns	
Turn-Off Fall Time (Note 12)	t_f	-	2.9	-	ns	

Notes: 10. Measured under pulsed conditions. Width $\leq 300\mu\text{s}$. Duty cycle $\leq 2\%$.
 11. For design aid only, not subject to production testing.
 12. Switching characteristics are independent of operating junction temperature.

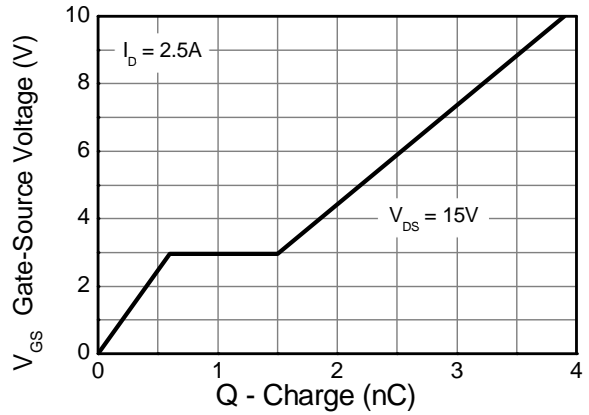
Typical Electrical Characteristics – Q1 N-Channel



Typical Electrical Characteristics – Q1 N-Channel - Continued

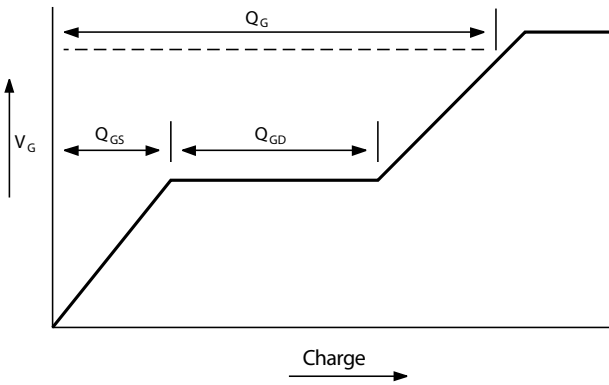


Capacitance v Drain-Source Voltage

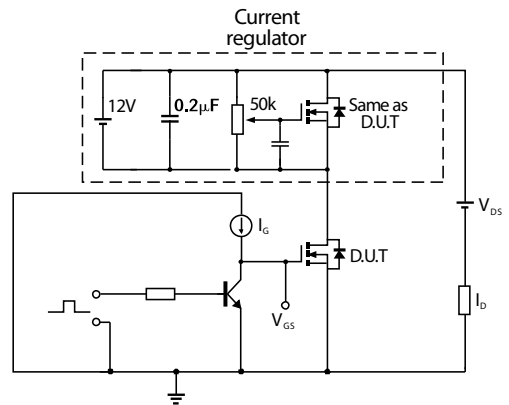


Gate-Source Voltage v Gate Charge

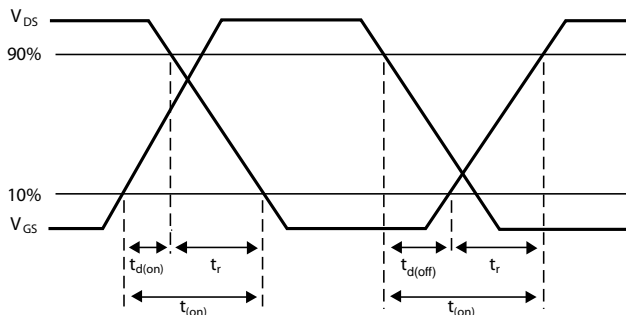
Test Circuits



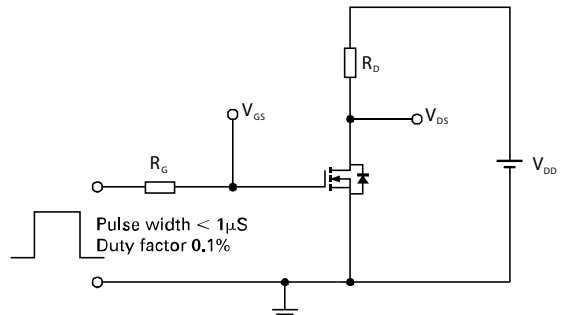
Basic gate charge waveform



Gate charge test circuit



Switching time waveforms



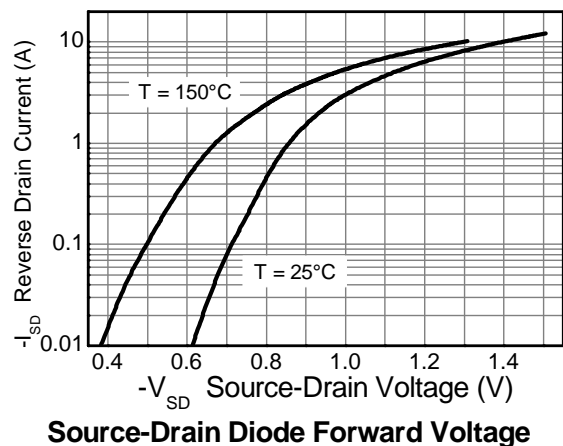
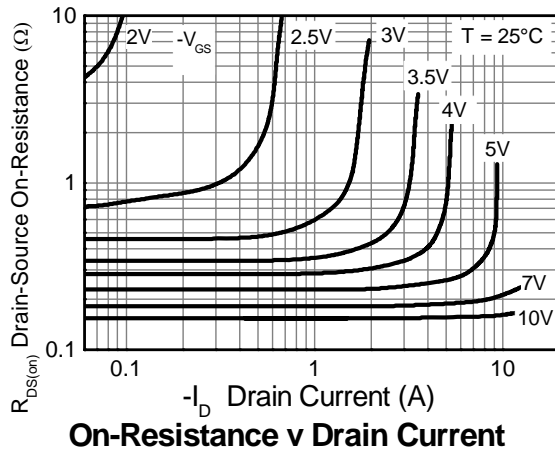
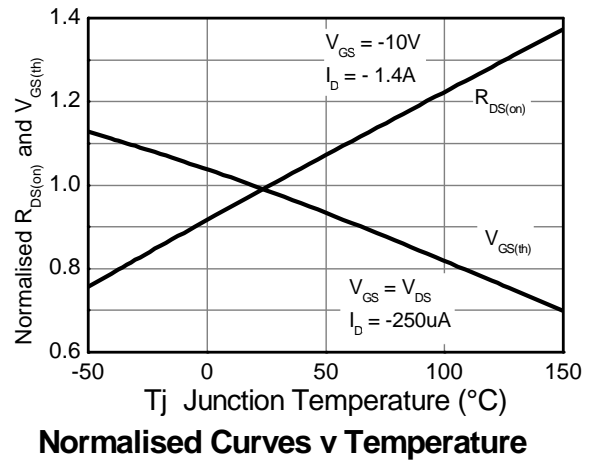
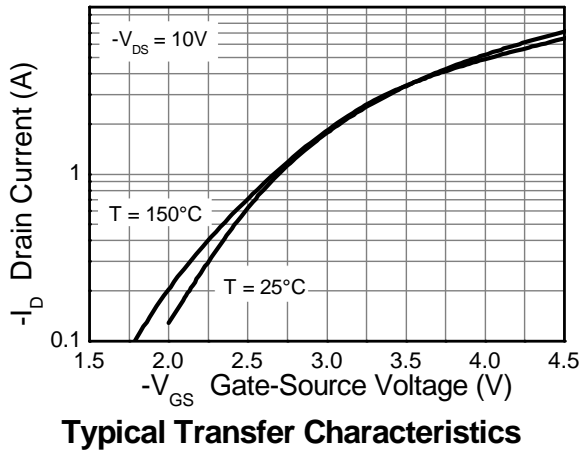
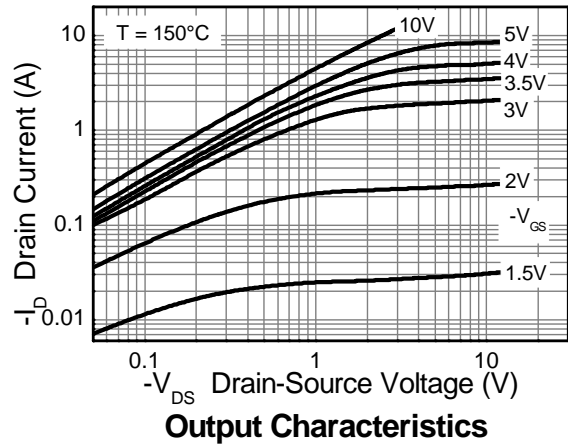
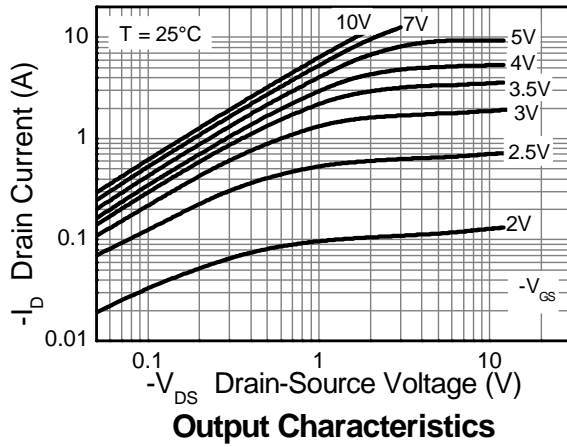
Switching time test circuit

Electrical Characteristics – Q2 P-Channel @T_A = 25°C unless otherwise specified

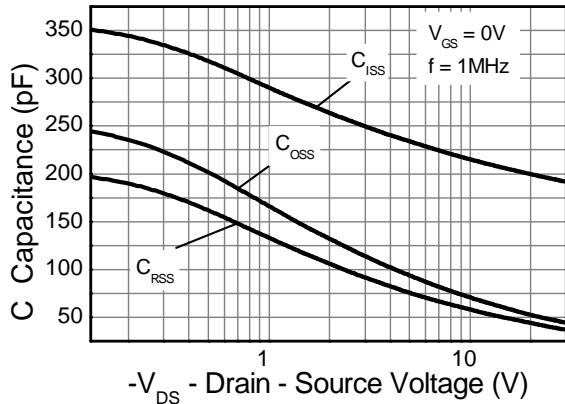
Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV _{DSS}	-30	-	-	V	I _D = -250μA, V _{GS} = 0V
Zero Gate Voltage Drain Current	I _{DSS}	-	-	-0.5	μA	V _{DS} = -30V, V _{GS} = 0V
Gate-Source Leakage	I _{GSS}	-	-	±100	nA	V _{GS} = ±20V, V _{DS} = 0V
ON CHARACTERISTICS						
Gate Threshold Voltage	V _{GS(th)}	-1.0	-	-3.0	V	I _D = -250μA, V _{DS} = V _{GS}
Static Drain-Source On-Resistance (Note 13)	R _{DS(on)}	-	0.150	0.210	Ω	V _{GS} = -10V, I _D = -1.4A
			0.280	0.330		V _{GS} = -4.5V, I _D = -1.1A
Forward Transconductance (Note 13 & 14)	g _{fs}	-	2.48	-	S	V _{DS} = -15V, I _D = -1.4A
Diode Forward Voltage (Note 13)	V _{SD}	-	-0.85	-0.95	V	I _S = -1.1A, V _{GS} = 0V
Reverse Recover Time (Note 14)	t _{rr}	-	18.6	-	ns	I _S = -0.95A, di/dt = 100A/μs
Reverse Recover Charge (Note 14)	Q _{rr}	-	14.8	-	nC	
DYNAMIC CHARACTERISTICS (Note 14)						
Input Capacitance	C _{iSS}	-	206	-	pF	V _{DS} = -15V, V _{GS} = 0V, f = 1.0MHz
Output Capacitance	C _{oss}	-	59.3	-	pF	
Reverse Transfer Capacitance	C _{rSS}	-	49.2	-	pF	
Total Gate Charge (Note 15)	Q _g	-	3.8	-	nC	V _{GS} = -4.5V
Total Gate Charge (Note 15)	Q _g	-	6.4	-	nC	V _{GS} = -10V
Gate-Source Charge (Note 15)	Q _{gs}	-	0.69	-	nC	
Gate-Drain Charge (Note 15)	Q _{gd}	-	2.0	-	nC	
Turn-On Delay Time (Note 15)	t _{D(on)}	-	1.5	-	ns	V _{DS} = -15V, I _D = -1A V _{GS} = -10V, R _G = 6Ω
Turn-On Rise Time (Note 15)	t _r	-	2.8	-	ns	
Turn-Off Delay Time (Note 15)	t _{D(off)}	-	11.3	-	ns	
Turn-Off Fall Time (Note 15)	t _f	-	7.5	-	ns	

Notes: 13. Measured under pulsed conditions. Width ≤ 300μs. Duty cycle ≤ 2%.
 14. For design aid only, not subject to production testing.
 15. Switching characteristics are independent of operating junction temperature.

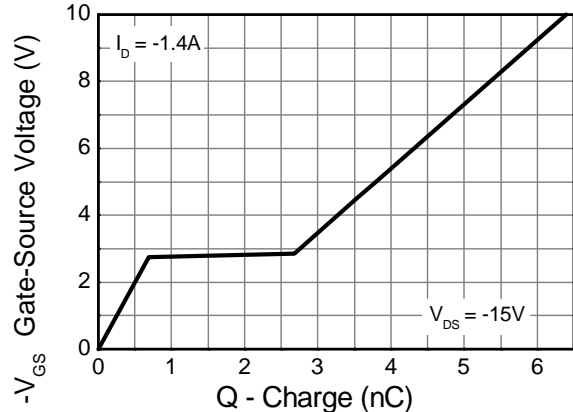
Typical Electrical Characteristics – Q2 P-Channel



Typical Electrical Characteristics – Q2 P-Channel - Continued

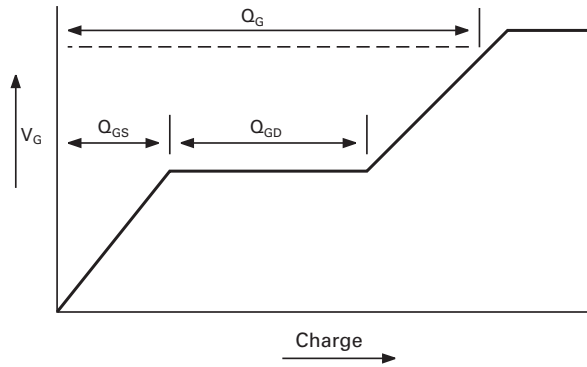


Capacitance v Drain-Source Voltage

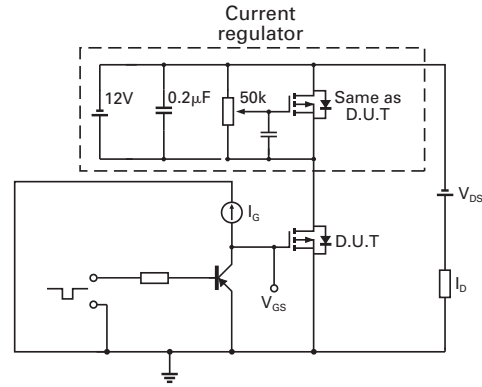


Gate-Source Voltage v Gate Charge

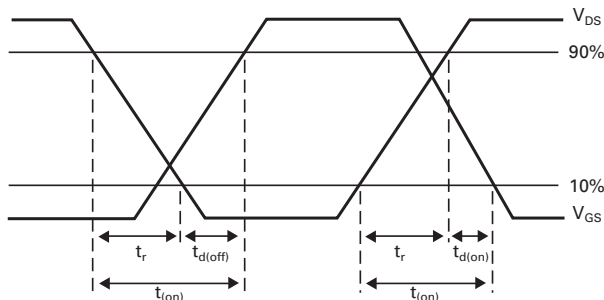
Test Circuits



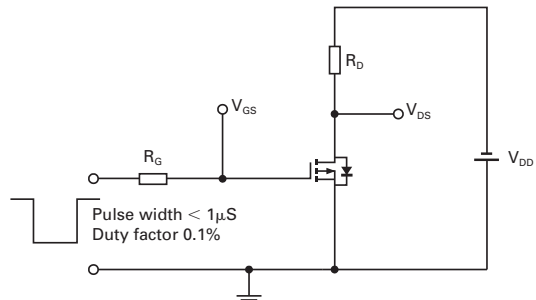
Basic gate charge waveform



Gate charge test circuit



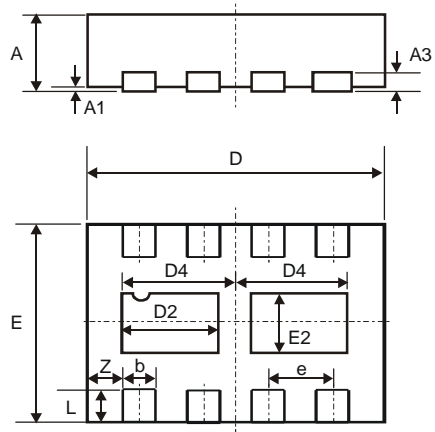
Switching time waveforms



Switching time test circuit

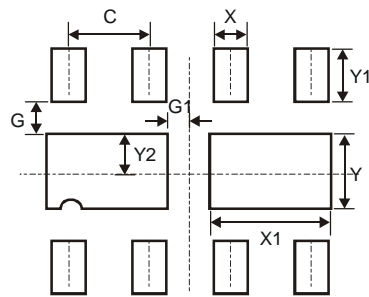
ZXMC3AMC

Package Outline Dimensions



DFN3020B-8			
Dim	Min	Max	Typ
A	0.77	0.83	0.80
A1	0	0.05	0.02
A3	-	-	0.15
b	0.25	0.35	0.30
D	2.95	3.075	3.00
D2	0.82	1.02	0.92
D4	1.01	1.21	1.11
e	-	-	0.65
E	1.95	2.075	2.00
E2	0.43	0.63	0.53
L	0.25	0.35	0.30
Z	-	-	0.375
All Dimensions in mm			

Suggested Pad Layout



Dimensions	Value (in mm)
C	0.650
G	0.285
G1	0.090
X	0.400
X1	1.120
Y	0.730
Y1	0.500
Y2	0.365

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- Техническую поддержку проекта.
- Защиту от снятия компонента с производства.
- Оценку стоимости проекта по компонентам.
- Изготовление тестовой платы монтаж и пусконаладочные работы.



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